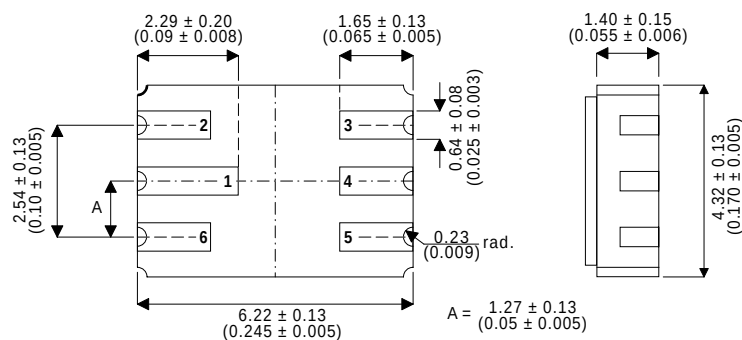


HIGH VOLTAGE, MEDIUM POWER, NPN DUAL TRANSISTOR IN A HERMETICALLY SEALED CERAMIC SURFACE MOUNT PACKAGE FOR HIGH RELIABILITY APPLICATIONS

MECHANICAL DATA

Dimensions in mm (inches)



LCC2 PACKAGE

Underside View

PAD 1 – Collector 1 PAD 4 – Collector 2
PAD 2 – Base 1 PAD 5 – Emitter 2
PAD 3 – Base 2 PAD 6 – Emitter 1

FEATURES

- DUAL SILICON PLANAR EPITAXIAL NPN TRANSISTOR
- HERMETIC CERAMIC SURFACE MOUNT PACKAGE
- CECC SCREENING OPTIONS
- SPACE QUALITY LEVELS OPTIONS
- HIGH VOLTAGE

APPLICATIONS:

Dual Hermetically sealed surface mount version of the popular 2N3700 for high reliability/ space applications requiring small size and low weight devices.

ABSOLUTE MAXIMUM RATINGS

($T_{case} = 25^{\circ}C$ unless otherwise stated)

2N3700

V_{CBO}	Collector – Base Voltage	140V
V_{CEO}	Collector – Emitter Voltage ($I_B = 0$)	80V
V_{EBO}	Emitter – Base Voltage ($I_B = 0$)	7V
I_C	Collector Current	1A
P_D	Per Device Dissipation	350mW
P_D	Total Device Dissipation	525mW
P_D	Derate above $25^{\circ}C$ (Per Device)	2mW / $^{\circ}C$
	(Total)	3mW/ $^{\circ}C$
R_{ja}	Thermal Resistance Junction to Ambient	240 $^{\circ}C/W$
T_{stg}	Storage Temperature	-65 to 200 $^{\circ}C$

ELECTRICAL CHARACTERISTICS (per Device) ($T_{\text{case}} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{\text{CEO(sus)}}^*$ Collector – Emitter Sustaining Voltage ($I_B = 0$)	$I_C = 10\text{mA}$	80			V
I_{CBO}^* Collector – Base Cut-off Current ($I_E = 0$)	$V_{\text{CB}} = 90\text{V}$			10	nA
	$V_{\text{CB}} = 90\text{V}$ $T_{\text{amb}} = 150^{\circ}\text{C}$			10	μA
I_{EBO}^* Emitter Cut-off Current ($I_C = 0$)	$V_{\text{EB}} = 5\text{V}$			10	nA
$V_{\text{CE(sat)}}^*$ Collector – Emitter Saturation Voltage	$I_C = 150\text{mA}$ $I_B = 15\text{mA}$			0.2	V
	$I_C = 500\text{mA}$ $I_B = 50\text{mA}$			0.5	V
$V_{\text{BE(sat)}}^*$ Base – Emitter Saturation Voltage	$I_C = 150\text{mA}$ $I_B = 15\text{mA}$			1.1	V
h_{FE}^* DC Current Gain ($V_{\text{CE}} = 10\text{V}$)	$I_C = 0.1\text{mA}$ $V_{\text{CE}} = 10\text{V}$	50			-
	$I_C = 10\text{mA}$ $V_{\text{CE}} = 10\text{V}$	90			-
	$I_C = 150\text{mA}$ $V_{\text{CE}} = 10\text{V}$	100		300	-
	$I_C = 500\text{mA}$ $V_{\text{CE}} = 10\text{V}$	50			-
	$I_C = 1\text{A}$ $V_{\text{CE}} = 10\text{V}$	15			-
	$I_C = 150\text{mA}$ $V_{\text{CE}} = 10\text{V}$				-
$V_{\text{(BR)CBO}}$ Collector-base Breakdown Voltage ($I_E = 0$)	$I_C = 100\mu\text{A}$	140			V
$V_{\text{(BR)EBO}}$ Emitter-base Breakdown Voltage ($I_C = 0$)	$I_E = 100\mu\text{A}$	7			V

* Pulse test $t_p = 300\mu\text{s}$, $\delta \leq 1\%$

DYNAMIC CHARACTERISTICS ($T_{\text{case}} = 25^{\circ}\text{C}$ unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
f_T Transition Frequency	$I_C = 50\text{mA}$ $V_{\text{CE}} = 10\text{V}$ $f = 20\text{MHz}$	100		200	MHz
h_{fe} Small Signal Current Gain	$I_C = 1\text{mA}$ $V_{\text{CE}} = 5\text{V}$ $f = 1\text{kHz}$	80		400	-
C_{EBO} Emitter-base Capacitance	$I_C = 0$ $V_{\text{EB}} = 0.5\text{V}$ $f = 1\text{MHz}$			60	pF
C_{CBO} Collector-base Capacitance	$I_C = 0$ $V_{\text{CB}} = 10\text{V}$ $f = 1\text{MHz}$			12	pF
τ_{fbb} $C_{\text{b'c}}$ Feedback time constant	$I_C = 10\text{mA}$ $V_{\text{CB}} = 10\text{V}$ $f = 4\text{MHz}$	25		400	ps